IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Kensaku Motoki, et al.

Serial No.:

To Be Assigned

Art Unit: To Be Assigned

Filed:

Herewith

Examiner: To Be Assigned

For :

GaN SINGLE CRYSTAL SUBSTRATE AND METHOD

OF MAKING THE SAME

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to the duty of disclosure under 37 C.F.R. § 1.56, Applicants are enclosing an Information Disclosure Citation Form (PTO-1449).

These documents were cited by the Examiner and the Applicants during prosecution of the predecessor application 09/560,818 filed April 28, 2000. No copies of the documents are necessary in accordance with 37 C.F.R. §1.98(d).

Applicants respectfully ask that each of these documents be made officially of record in this application, and that a listing of the same appear on the face of any patent which may issue from this application.

Respectfully submitted, SMITH, GAMBRELL & RUSSELL, LLP

Michael A. Makuch, Reg. No. 32,263

1850 M Street, N.W., Suite 800

Washington, D.C. 20036 Telephone: (202) 263-4300 Facsimile: (202) 263-4329

October 24, 2003

ATTY. DOCKET NO. 33035M0342	SERIAL NO. To Be Assigned			
APPLICANTS: Kensaku Motoki, et al.				
FILING DATE Herewith GROUP ART UN To Be Assigned				
	33035M0342 APPLICANTS: Kensaku Motoki, et al. FILING DATE			

U.S. Patent Documents

Examiner Initials		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE, IF APPROPRIATE
	AA	4,727,047	2/1988	Bozler, et al.			
	AB	6,225,650	5/2001	Tadatomo et al.			
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	AG	6,156,581	12/2000	Vaudo et al.			

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	AD	09-194299	7/29/97	Japan			Abstract	
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OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER	DATE CONSIDERED							
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation								
if not in conformance and not considered. Include copy of this fo	rm with next communication to applicant.							

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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT					ATTY. DOCKET NO. 33035M0342			SERIAL NO. To Be Assigned			
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	AN	Forms PCT/IB	/304 and	PCT/IB/308.							
	AO	Korean Office	Action r	nailed April 23,	2003						
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